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Application/Control No.	n/Control No. Applicant(s)/Patent under Reexamination	
10/792,244	HEMBREE, DAVID R.	
Examiner	Art Unit	
James M. Mitchell	2813	

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Est Gerprintout)	1/11/07	244		
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